

Notice of References Cited	Application/Control No. 10/551,585		Applicant(s)/Patent Under Reexamination LEACH ET AL.	
	Examiner HIEN NGUYEN		Art Unit 3768	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2003/0035583	02-2003	Pelagotti et al.	382/217
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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